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Application/Control No.	Applicant(s)/Patent under Reexamination	-
10/569,793	KANAI ET AL.	
Examiner	Art Unit	_
Michelle Lopez	3721	

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Class	Subclass	Date	Examiner
227 .	120 154 155	1/8/2007	ML
227	82 85-87 89	1/8/2007	ML
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Inventor names search on East - see attached history	1/8/2007	ML
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